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Report Template Version: V05

Report Template Revision Date: 2021-11-03

RF Exposure Evaluation Report

Report No.: CQASZ20220300458E-02
Applicant: Wanney Corporation
Address of Applicant: Room 401, Building 2, Shanghenglang new industrial zone, Tongsheng community, Dalang Street, Longhua District, Shenzhen, China
Equipment Under Test (EUT):
EUT Name: Night Vision Device
Test Model No.: NVE-E53, WNPWR-P502A, WNPWR-P60A, WNPWR-P61A, WNPWR-P62A, WNPWR-P70A, WNPWR-P72A, NVE-B33, NVE-B33S, NVE-D20, NVE-D30, NVE-D31, NVE-D31S, NVE-D33, NVE-D35, NVE-E50, NVE-E50-II, NVE-E50-II Plus, XANS500, XANS550, NVE-E53A/B/C/D, NVE-E55, NVE-E55A/B/C/D, NVE-E57, NVE-E57A/B/C/D, E50-II Plus, E53, D31, D31S
Model No.: NVE-E53
Brand Name: WANNEY
FCC ID: 2A526NVE-53
Standards: 47 CFR Part 1.1307
47 CFR Part 2.1093
447498 D04 Interim General RF Exposure Guidance v01
Date of Receipt: 2022-03-28
Date of Test: 2022-03-28 to 2022-05-12
Date of Issue: 2022-05-16
Test Result: PASS*

*In the configuration tested, the EUT complied with the standards specified above

Tested By:

Lewis Zhou

(Lewis Zhou)

Reviewed By:

Rock Huang

(Rock Huang)

Approved By:

Jack Ai

(Jack Ai)



The test report is effective only with both signature and specialized stamp, The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CQA, this report can't be reproduced except in full.

Version

Revision History Of Report

Report No.	Version	Description	Issue Date
CQASZ20220300458E-02	Rev.01	Initial report	2022-05-16

1 Contents

	Page
VERSION	2
1 CONTENTS	3
.....	3
2 GENERAL INFORMATION	4
2.1 CLIENT INFORMATION	4
2.2 GENERAL DESCRIPTION OF EUT	4
2.3 GENERAL DESCRIPTION OF WLAN	4
3 SAR EVALUATION	5
3.1 RF EXPOSURE COMPLIANCE REQUIREMENT	5
3.1.1 <i>Standard Requirement</i>	5
3.1.2 <i>Limits</i>	5
3.1.3 <i>EUT RF Exposure</i>	7

2 General Information

2.1 Client Information

Applicant:	Wanney Corporation
Address of Applicant:	Room 401, Building 2, Shanghenglang new industrial zone, Tongsheng community, Dalang Street, Longhua District, Shenzhen, China
Manufacturer:	Wanney Corporation
Address of Manufacturer:	Room 401, Building 2, Shanghenglang new industrial zone, Tongsheng community, Dalang Street, Longhua District, Shenzhen, China
Factory:	Wanney Corporation
Address of Factory:	Room 401, Building 2, Shanghenglang new industrial zone, Tongsheng community, Dalang Street, Longhua District, Shenzhen, China

2.2 General Description of EUT

Product Name:	Night Vision Device
Model No.:	NVE-E53, WNPWR-P502A, WNPWR-P60A, WNPWR-P61A, WNPWR-P62A, WNPWR-P70A, WNPWR-P72A, NVE-B33, NVE-B33S, NVE-D20, NVE-D30, NVE-D31, NVE-D31S, NVE-D33, NVE-D35, NVE-E50, NVE-E50-II, NVE-E50-II Plus, XANS500, XANS550, NVE-E53A/B/C/D, NVE-E55, NVE-E55A/B/C/D, NVE-E57, NVE-E57A/B/C/D, E50-II Plus, E53, D31, D31S
Test Model No	NVE-E53
Trade Mark:	WANNEY
EUT Supports Radios application:	2.4GHz: Wi-Fi: 802.11b/g/n(HT20): 2412MHz~2462MHz;
Software Version:	V6
Hardware Version:	NVRS_MAINBOARD_V4
Sample Type:	☐ Mobile ☒ Portable ☐ Fix Location
EUT Power Supply:	Li-ion battery: DC 3.75V 3350mAh, Charge by DC 5V for adapter

2.3 General Description of WLAN

Operation Frequency:	IEEE 802.11b/g/n(HT20): 2412MHz to 2462MHz
Modulation Type:	IEEE for 802.11b: DSSS(CCK,DQPSK,DBPSK) IEEE for 802.11g : OFDM(64QAM, 16QAM, QPSK, BPSK) IEEE for 802.11n(HT20) : OFDM (64QAM, 16QAM, QPSK, BPSK)
Number of Channel:	IEEE 802.11b/g, IEEE 802.11n HT20: 11 Channels
Transfer Rate:	IEEE for 802.11b: 1Mbps/2Mbps/5.5Mbps/11Mbps IEEE for 802.11g : 6Mbps/9Mbps/12Mbps/18Mbps/24Mbps/36Mbps/48Mbps/54Mbps IEEE for 802.11n(HT20) : 6.5Mbps/13Mbps/19.5Mbps/26Mbps/39Mbps/52Mbps/58.5Mbps/65Mbps
Test Software of EUT:	RF Test
Antenna Type:	internal antenna (PCB trace)
Antenna Gain:	6dBi

3 SAR Evaluation

3.1 RF Exposure Compliance Requirement

3.1.1 Standard Requirement

447498 D04 Interim General RF Exposure Guidance v01

3.2. SAR Test Reduction Guidance

SAR test reduction procedures [Glossary] allow using a particular set of test data as representative of other, similar, test conditions. This may be applied for data within different test positions (e.g. body, head, extremity), wireless modes (e.g. Wi-Fi, cellular), and frequency bands. This test reduction process provides for the use of test data for one specific channel, while referencing to those data for demonstrating compliance in other required channels for each test position of an exposure condition, within the operating mode of a frequency band. This is limited specifically to when the reported 1-g or 10-g SAR for the mid-band or highest output power channel meets any of the following conditions.

3.1.2 Limits

SAR-based thresholds are derived based on frequency, power, and separation distance of the RF source. The formula defines the thresholds in general for either available maximum time averaged power or maximum time-averaged ERP, whichever is greater.

If the ERP of a device is not easily determined, such as for a portable device with a small form factor, the applicant may use the available maximum time-averaged power exclusively if the device antenna or radiating structure does not exceed an electrical length of $\lambda/4$.

As for devices with antennas of length greater than $\lambda/4$ where the gain is not well defined, but always less than that of a half-wave dipole (length $\lambda/2$), the available maximum time-averaged power generated by the device may be used in place of the maximum time-averaged ERP, where that value is not known.

The separation distance is the smallest distance from any part of the antenna or radiating structure for all persons, during operation at the applicable ERP. In the case of mobile or portable devices, the separation distance is from the outer housing of the device where it is closest to the antenna.

The SAR-based exemption formula of § 1.1307(b)(3)(i)(B), repeated here as Formula (B.2), applies for single fixed, mobile, and portable RF sources with available maximum time-averaged power or effective radiated power (ERP), whichever is greater, of less than or equal to the threshold P_{th} (mW).

This method shall only be used at separation distances from 0.5 cm to 40 cm and at frequencies from 0.3 GHz to 6 GHz (inclusive). P_{th} is given by Formula (B.2).

$$P_{th} \text{ (mW)} = \begin{cases} ERP_{20 \text{ cm}} (d/20 \text{ cm})^x & d \leq 20 \text{ cm} \\ ERP_{20 \text{ cm}} & 20 \text{ cm} < d \leq 40 \text{ cm} \end{cases} \quad (\text{B.2})$$

where

$$x = -\log_{10} \left(\frac{60}{ERP_{20 \text{ cm}} \sqrt{f}} \right)$$

and f is in GHz, d is the separation distance (cm), and $ERP_{20 \text{ cm}}$ is per Formula (B.1).
The example values shown in Table B.2 are for illustration only.

Table B.2—Example Power Thresholds (mW)

Frequency (MHz)	Distance (mm)									
	5	10	15	20	25	30	35	40	45	50
300	39	65	88	110	129	148	166	184	201	217
450	22	44	67	89	112	135	158	180	203	226
835	9	25	44	66	90	116	145	175	207	240
1900	3	12	26	44	66	92	122	157	195	236
2450	3	10	22	38	59	83	111	143	179	219
3600	2	8	18	32	49	71	96	125	158	195
5800	1	6	14	25	40	58	80	106	136	169

3.1.3 EUT RF Exposure

Measurement Data

Channel	Maximum Peak Conducted Output Power (dBm)	Maximum tune-up Power (mW)	Exclusion threshold (mW)
Lowest (2412MHz)	3.30	2.138	3.0
Middle (2442MHz)	2.49	1.774	
Highest (2472MHz)	2.91	1.954	

Remark: The Max Conducted Peak Output Power data refer to report Report No.: CQASZ20220300458E-01.

*** END OF REPORT ***